

**TOPAZ**  
SEMICONDUCTOR

**TZ404**

## N-CHANNEL ENHANCEMENT-MODE D-MOS FET ULTRA HIGH-SPEED LOW-COST SWITCH

### ORDERING INFORMATION

TO-92 Plastic Package	TZ404BD
SOT-89 Surface Mount Package	TZ404CY
Description	20V, 8 ohm

### FEATURES

- Reliable, Low Cost, Plastic Package
- High Speed Switching,  $t_r < 2\text{nSec}$
- Low Capacitance,  $c_{rss} 1.2 \text{ pF typ}$
- CMOS and TTL Compatible Input
- Available in Surface Mount Package

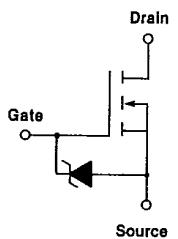
### APPLICATIONS

- Switch Drivers
- Video Switches
- VHF/UHF Amplifiers

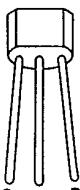
### ABSOLUTE MAXIMUM RATINGS ( $T_A = +25^\circ\text{C}$ unless otherwise specified)

Drain-Source Voltage .....	+ 20V	Peak Pulsed Drain Current .....	+ 0.8A
Gate-Source Voltage .....	-0.3V	Continuous Drain Current .....	100mA
	+ 20V	Power Dissipation (at or below $T_A = +25^\circ\text{C}$ ) .....	300mW
Gate-Drain Voltage .....	-0.3V	Linear Derating Factor .....	3.0mW/ $^\circ\text{C}$
	+ 20V	Operating Junction and	
Source-Drain Voltage .....	-0.3V	Storage Temperature Range.....	-40 $^\circ\text{C}$ to +125 $^\circ\text{C}$

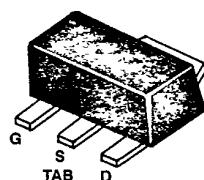
### PIN CONFIGURATIONS



TO-92



SOT-89



### PACKAGE DIMENSIONS TO-92

TO-226AA (TO-92)  
See Package 5

TO-243AA (SOT-89)  
See Package 23

T-35-25

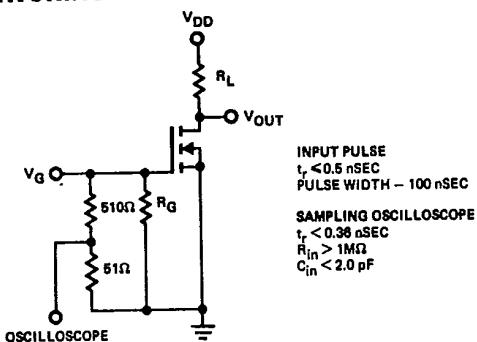
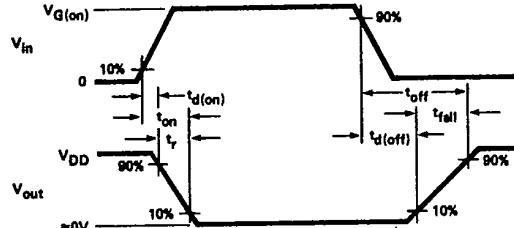
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**ELECTRICAL CHARACTERISTICS** ( $T_A = +25^\circ\text{C}$  unless otherwise specified)

CHARACTERISTIC		MIN	TYP	MAX	UNIT	TEST CONDITION
STATIC	BVDS Drain-Source Breakdown Voltage	20	25		V	$I_D = 1.0\mu\text{A}, V_{GS} = 0$
	$I_{D(\text{off})}$ Drain-Source OFF Leakage Current			1.0	$\mu\text{A}$	$V_{DS} = 15\text{V}, V_{GS} = 0$
	$I_{GSS}$ Gate-Source Leakage Current			10	$\mu\text{A}$	$V_{GS} = 20\text{V}, V_{DS} = 0$
	$I_{D(\text{on})}$ Drain-Source ON Current	0.8	1.2		A	$V_{DS} = 10\text{V}, V_{GS} = 10\text{V}$ (Note 1)
	$V_{GS(\text{th})}$ Gate-Source Threshold Voltage	0.7	1.1	1.5	V	$I_D = 1.0\mu\text{A}, V_{DS} = V_{GS}$
	$V_{DS(\text{on})}$ Drain-Source ON Voltage			200	mV	$I_D = 10\text{mA}$
	$r_{DS(\text{on})}$ Drain-Source ON Resistance			20	ohms	$V_{GS} = 2.4\text{V}$
	$V_{DS(\text{on})}$ Drain-Source ON Voltage			800	mV	$I_D = 100\text{mA}$
	$r_{DS(\text{on})}$ Drain-Source ON Resistance			8.0	ohms	$V_{GS} = 4.5\text{V}$
DYNAMIC	$g_{fs}$ Common-Source Forward Transcond.	100			mmhos	$I_D = 0.3\text{A} V_{DS} = 20\text{V}$ $f = 1\text{KHz}$
	$C_{iss}$ Common-Source Input Capacitance		12	18	pf	$V_{DS} = 20\text{V}, V_{GS} = 0$ $f = 1\text{MHz}$
	$C_{oss}$ Common-Source Output Capacitance		6.0	8.0		
	$C_{rss}$ Common-Source Reverse Transfer Capacitance		1.2	2.0		
	$t_{d(on)}$ Turn ON Delay Time		1.0	1.5	nS	$V_{DD} = 10\text{V}, R_L = 390\Omega$ $V_{G(\text{on})} = 10\text{V}, R_G = 51\Omega$ $C_L = 1.5\text{pF}$
	$t_r$ Rise Time		1.0	2.0		
	$t_{off}$ Turn OFF Time		1.0			

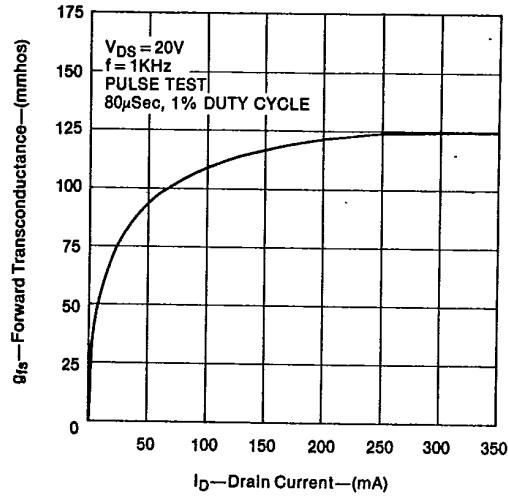
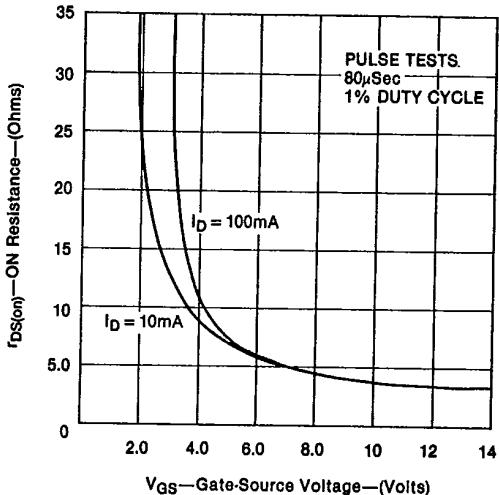
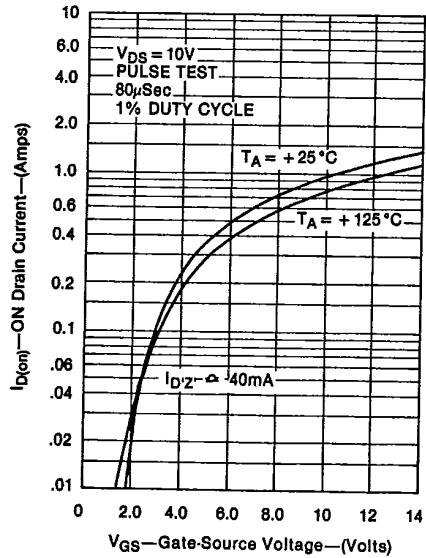
Note 1: Pulse Test, 80µSec, 1% Duty Cycle

**SWITCHING TIMES TEST CIRCUIT****TEST WAVEFORMS**

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T-35-25-

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**TYPICAL PERFORMANCE CHARACTERISTICS** ( $T_A = +25^\circ\text{C}$  unless otherwise specified)**FORWARD TRANSCONDUCTANCE**  
—vs—  
**ON DRAIN CURRENT****DRAIN-SOURCE ON RESISTANCE**  
—vs—  
**GATE-SOURCE VOLTAGE****ON DRAIN CURRENT**  
—vs—  
**GATE-SOURCE VOLTAGE****CAPACITANCES**  
—vs—  
**DRAIN-SOURCE VOLTAGE**